

Notice of References Cited	Application/Control No. 10/661,503	Applicant(s)/Patent Under Reexamination HIKAWA ET AL.	
	Examiner PHILIP C. LEE	Art Unit 2452	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,815,152	09-1998	Collier et al.	715/839
*	B	US-6,122,633	09-2000	Leymann et al.	707/10
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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